

**Notice of References Cited**

Application/Control No.

09/513,652

Applicant(s)/Patent Under  
Reexamination  
HANKO ET AL.

Examiner

Tammy T Nguyen

Art Unit

2143

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,298,422	10-2001	Spilo et al.	711/154
	B	US-6,014,748	01-2000	Tushie et al.	713/200
	C	US-6,397,053	05-2002	Ghiazza, Jean-Yves	455/343
	D	US-6,330,607	12-2001	Chmielewski et al.	709/227
	E	US-5,946,465	08-1999	Chmielewski et al.	709/226
	F	US-6,434,532	08-2002	Goldband et al.	705/7
	G	US-6,272,129	08-2001	Dynarski et al.	370/356
	H	US-6,393,569	05-2002	Orenshteyn, Alexander S.	713/201
	I	US-6,402,028	06-2002	Graham et al.	235/380
	J	US-5,778,385	07-1998	Pratt, John M.	707/200
	K	US-6,347,339	02-2002	Morris et al.	709/237
	L	US-6,212,564	04-2001	Harter et al.	709/228
	M	US-6,157,927	12-2000	Schaefer et al.	707/103R

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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	A	US-6,298,422	10-2001	Spilo et al.	711/154
	B	US-6,014,784	01-2000	Taylor et al.	5/713
	C	US-6,549,934	04-2003	Peterson et al.	709/203
	D	US-6,249,803	06-2001	Jindal et al.	709/203
	E	US-6,412,015	06-2002	Navare et al.	709/250
	F	US-6,411,986	06-2002	Susai et al.	709/203
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	B	US-6,411,986	06-2002	Susai et al.	709/203
	C	US-5,414,750	05-1995	Bhagat et al.	455/416
	D	US-6,061,726	05-2000	Cook et al.	709/226
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
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